

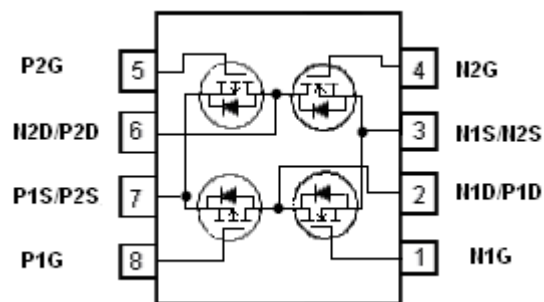
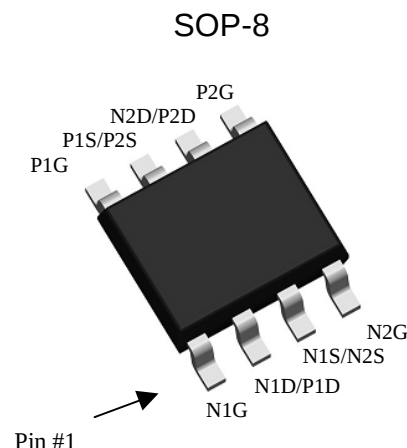
2N- and 2P-Channel Enhancement Mode MOSFET

Features:

- Simple drive requirement
- Low on-resistance
- Fast switching speed
- Pb-free lead plating and halogen-free package

Description :

The KSC9930 consists of two N-channel and two P-channel enhancement-mode MOSFET in a single SOP-8 package, providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness. The SOP-8 package is universally preferred for all commercial-industrial surface mount applications.



G : Gate S : Source D : Drain

	N-CH	P-CH
BV _{DSS}	30V	-30V
I _D	6A	-4.4A
RDSON(TYP.)	17mΩ	35mΩ

Ordering Information

Device	Package	Shipping
KSC9930	SOP-8 (Pb-free lead plating and halogen-free package)	4000 pcs / tape & reel

Absolute Maximum Ratings (T_c=25°C, unless otherwise noted)

Parameter		Symbol	Limits		Unit
			N-channel	P-channel	
Drain-Source Breakdown Voltage		BV _{DSS}	30	-30	V
Gate-Source Voltage		V _{GS}	±25	±25	
Continuous Drain Current (Note 2)	T _A =25 °C, V _{GS} =10V (-10V)	I _D	6	-4.4	A
	T _A =70 °C, V _{GS} =10V (-10V)		4.8	-3.5	
Pulsed Drain Current (Note 1)		I _{DM}	24	-20	
Power Dissipation	T _A =25°C	P _D	1.38		W
	T _A =70°C		0.88		
Operating Junction and Storage Temperature Range		T _j ; T _{stg}	-55~+150		°C

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	R _{θJC}	36	°C/W
Thermal Resistance, Junction-to-ambient, max	R _{θJA}	90 (Note 2)	

Note : 1.Pulse width limited by maximum junction temperature.

2.Surface mounted on 1 in² copper pad of FR-4 board, pulse width≤10s.

N-Channel Electrical Characteristics (T_c=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	30	-	-	V	V _{GS} =0V, I _D =250μA
V _{GS(th)}	1.0	-	2.5		V _{DS} =V _{GS} , I _D =250μA
I _{GSS}	-	-	±100	nA	V _{GS} =±25V, V _{DS} =0V
I _{DSS}	-	-	1	μA	V _{DS} =30V, V _{GS} =0V
	-	-	25		V _{DS} =24V, V _{GS} =0V, T _j =70°C
*R _{DS(ON)}	-	17	24	m∧	I _D =5A, V _{GS} =10V
	-	21	30		I _D =3A, V _{GS} =4.5V
*G _{FS}	-	6.7	-	S	V _{DS} =5V, I _D =5A
Dynamic					
C _{iss}	-	496	750	pF	V _{DS} =25V, V _{GS} =0V, f=1MHz
C _{oss}	-	61	-		
C _{rss}	-	47	-		
*t _{d(ON)}	-	6.2	-	ns	V _{DS} =15V, I _D =1A, V _{GS} =10V, R _G =6Ω
*t _r	-	17.2	-		
*t _{d(OFF)}	-	30.2	-		
*t _f	-	7.6	-		
*Q _g	-	5.6	9	nC	V _{DS} =15V, I _D =6A, V _{GS} =4.5V
*Q _{gs}	-	1.9	-		
*Q _{gd}	-	2.1	-		
Body Diode					
*V _{SD}	-	0.78	1.2	V	V _{GS} =0V, I _S =1.2A
*t _{rr}	-	7.7	-	ns	I _F =5A, dI _F /dt=100A/μs
*Q _{rr}	-	3.3	-	nC	

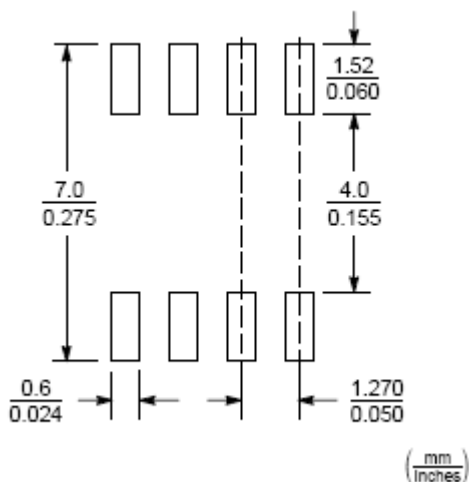
*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

P-Channel Electrical Characteristics (Tc=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	-30	-	-	V	V _{GS} =0V, I _D =-250μA
V _{GS(th)}	-1.0	-	-2.5		V _{DS} =V _{GS} , I _D =-250μA
I _{GSS}	-	-	±100	nA	V _{GS} =±25V, V _{DS} =0V
I _{DSS}	-	-	-1	μA	V _{DS} =-30V, V _{GS} =0V
	-	-	-25		V _{DS} =-24V, V _{GS} =0V, T _j =70°C
*R _{DS(ON)}	-	35	48	mΛ	I _D =-4A, V _{GS} =-10V
	-	46	70		I _D =-2A, V _{GS} =-4.5V
*G _{FS}	-	7.8	-	S	V _{DS} =-10V, I _D =-5A
Dynamic					
C _{iss}	-	597	900	pF	V _{DS} =-25V, V _{GS} =0V, f=1MHz
C _{oss}	-	63	-		
C _{rss}	-	51	-		
*t _{d(ON)}	-	5.6	-	ns	V _{DS} =-15V, I _D =-1A, V _{GS} =-10V, R _G =6Ω
*t _r	-	17.6	-		
*t _{d(OFF)}	-	64.4	-		
*t _f	-	33.8	-		
*Q _g	-	6.7	11	nC	V _{DS} =-15V, I _D =-4.4A, V _{GS} =-4.5V
*Q _{gs}	-	2.2	-		
*Q _{gd}	-	2.5	-		
Body Diode					
*V _{SD}	-	-0.78	-1.2	V	V _{GS} =0V, I _S =-1.2A
*t _{rr}	-	7.7	-	ns	I _F =-4.5A, dI _F /dt=100A/μs
*Q _{rr}	-	3.0	-	nC	

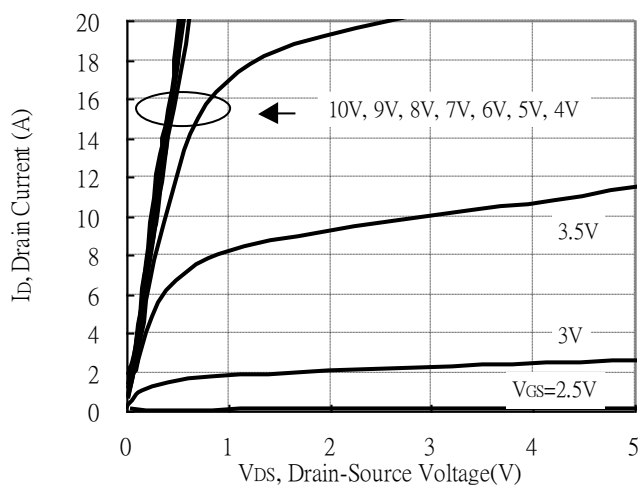
*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

Recommended Soldering Footprint

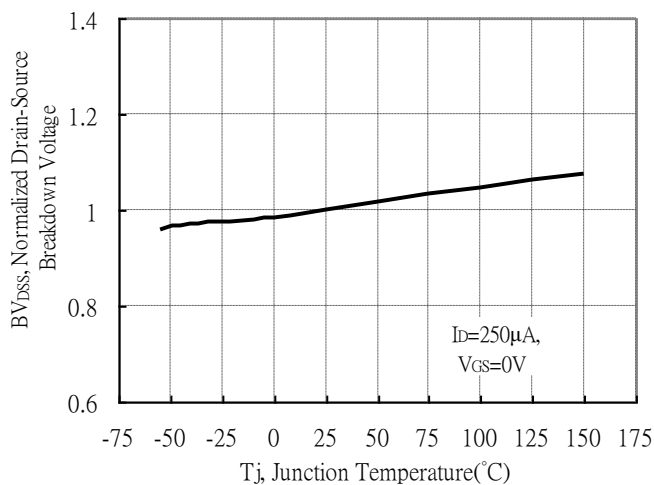


Typical Characteristics : Q1(N-channel)

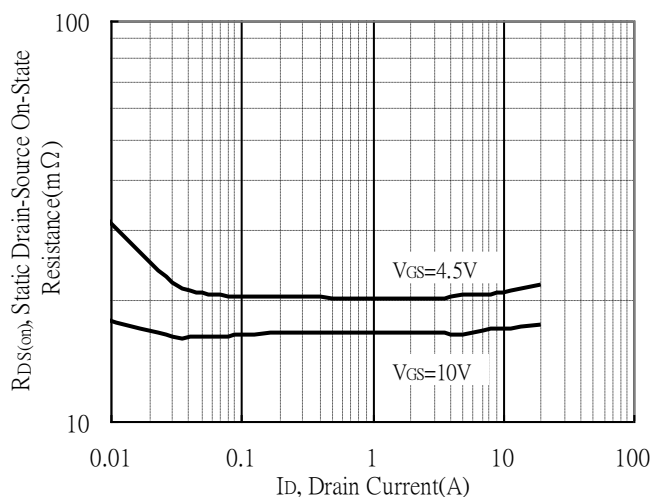
Typical Output Characteristics



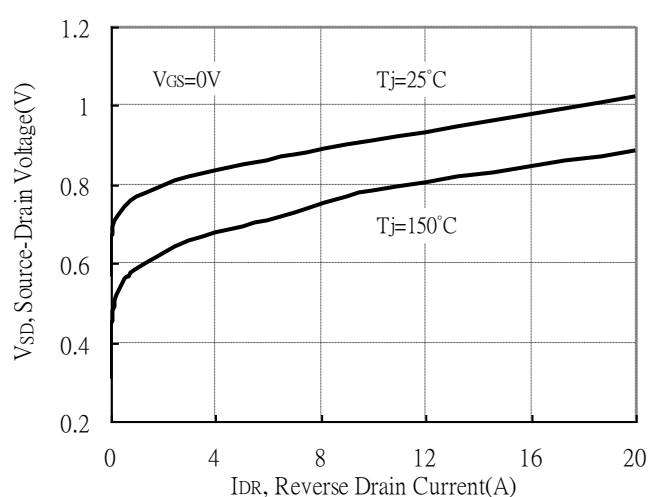
Breakdown Voltage vs Ambient Temperature



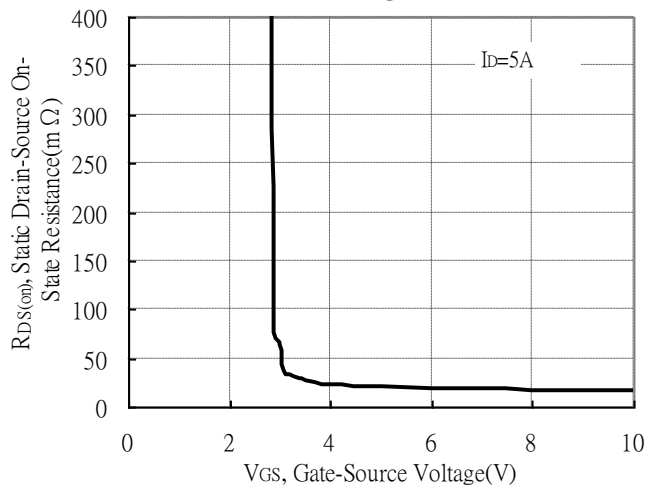
Static Drain-Source On-State resistance vs Drain Current



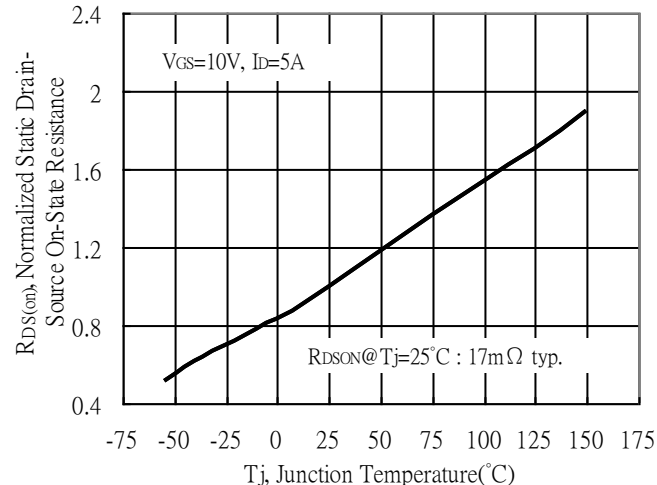
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

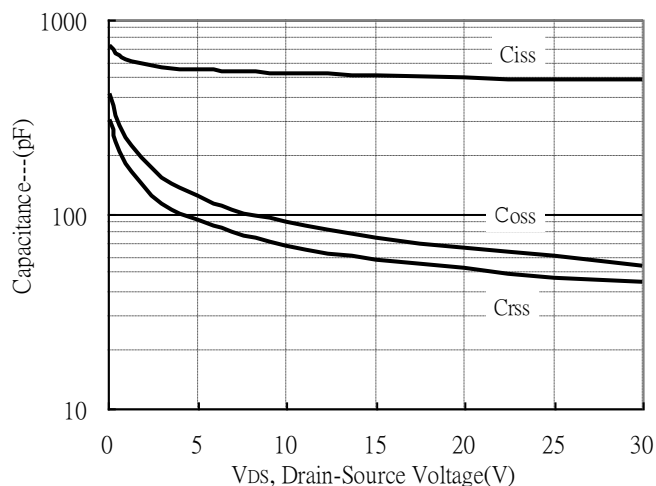


Drain-Source On-State Resistance vs Junction Temperature

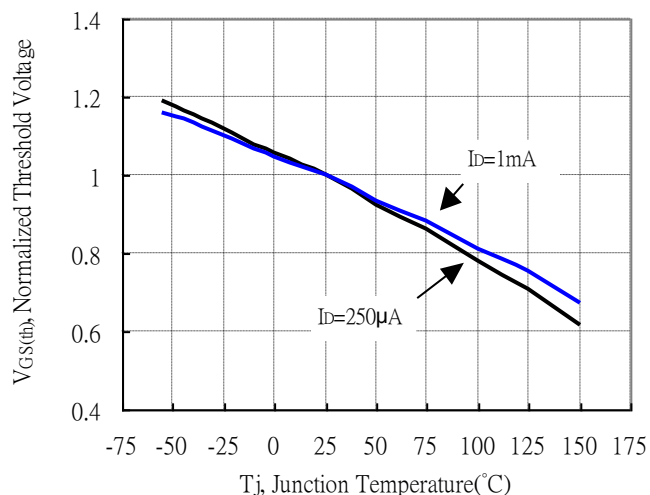


Typical Characteristics(Cont.) : Q1(N-channel)

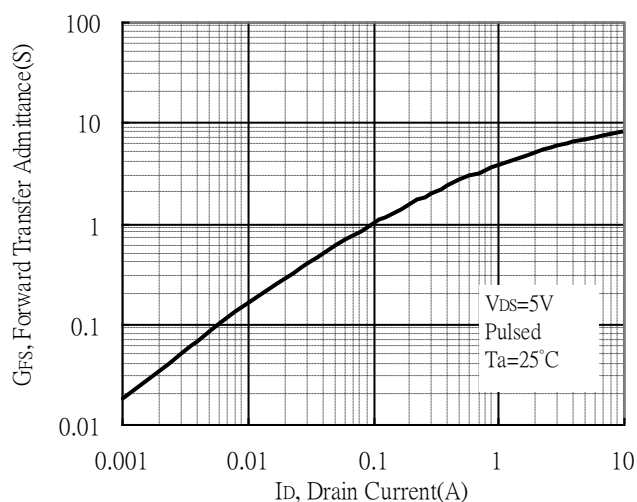
Capacitance vs Drain-to-Source Voltage



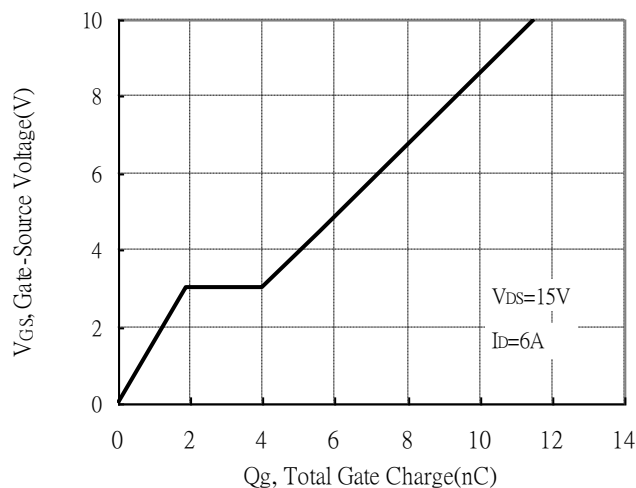
Threshold Voltage vs Junction Temperature



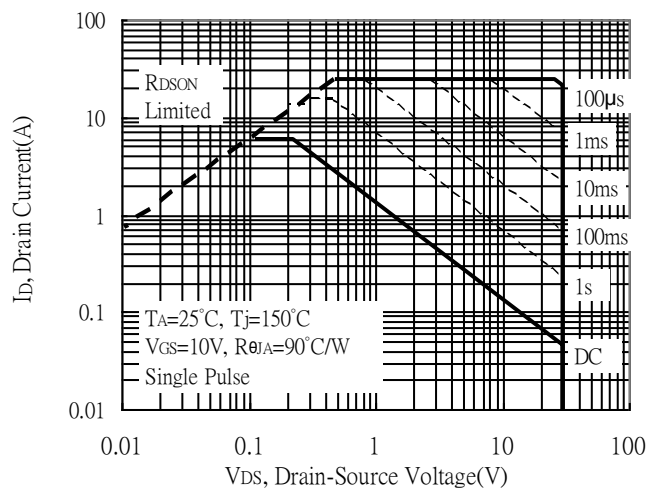
Forward Transfer Admittance vs Drain Current



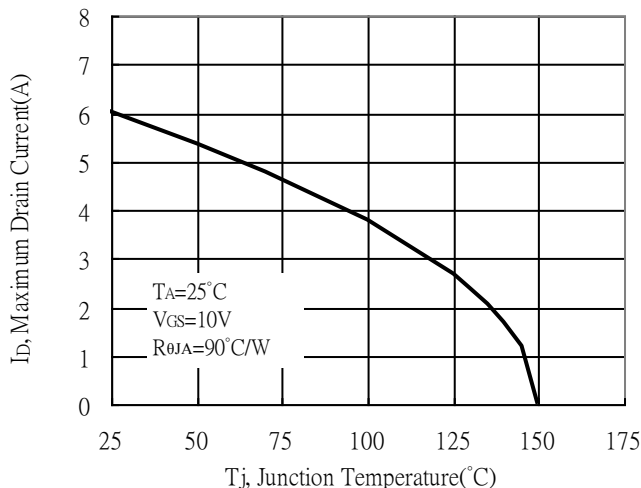
Gate Charge Characteristics



Maximum Safe Operating Area

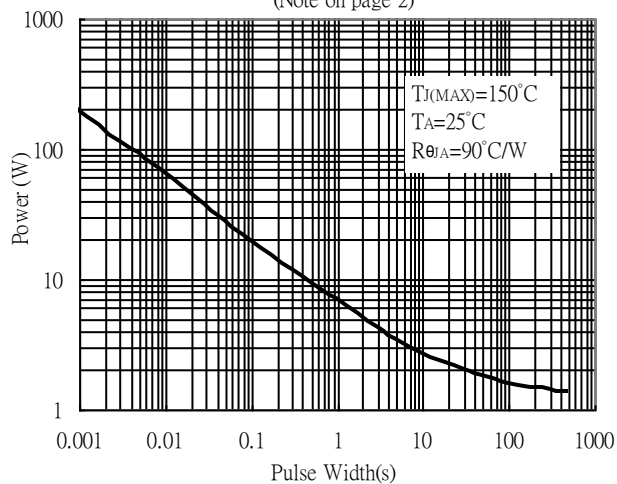


Maximum Drain Current vs Junction Temperature

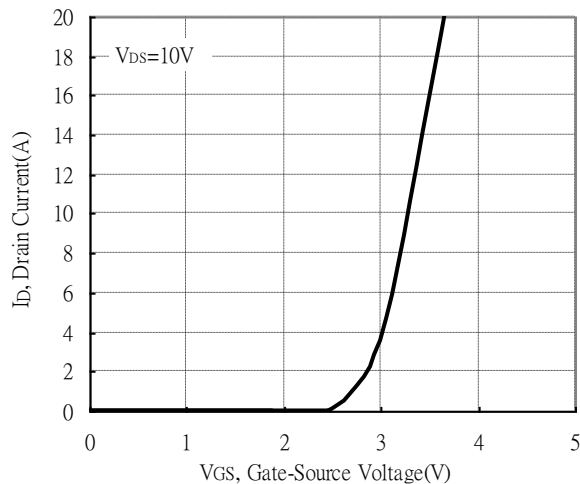


Typical Characteristics(Cont.) : Q1(N-channel)

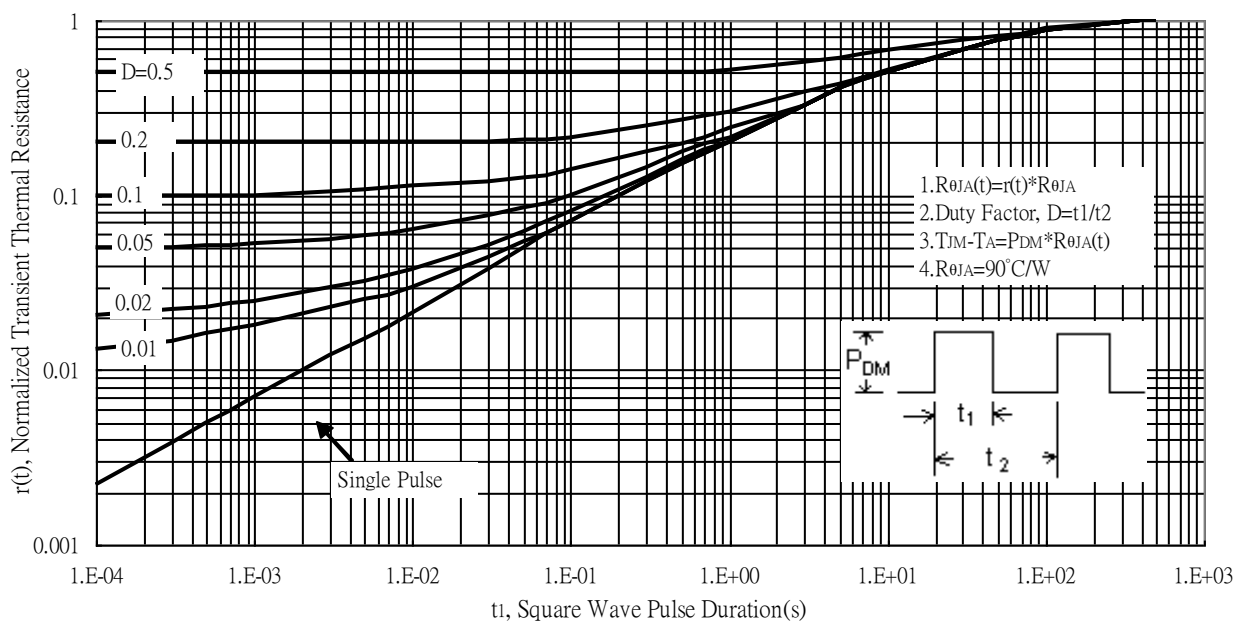
Single Pulse Power Rating, Junction to Ambient
 (Note on page 2)



Typical Transfer Characteristics

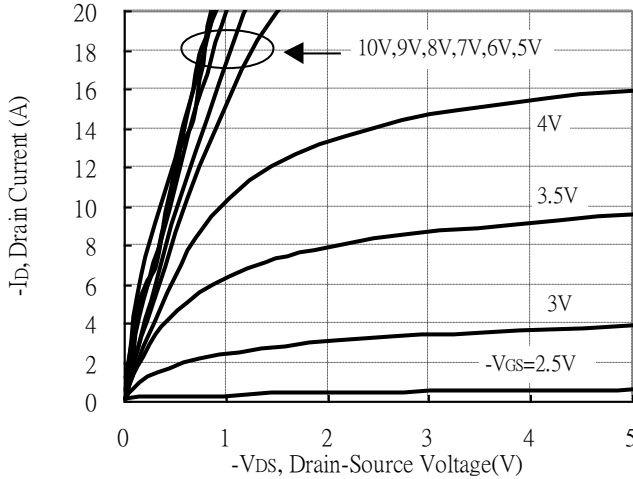


Transient Thermal Response Curves

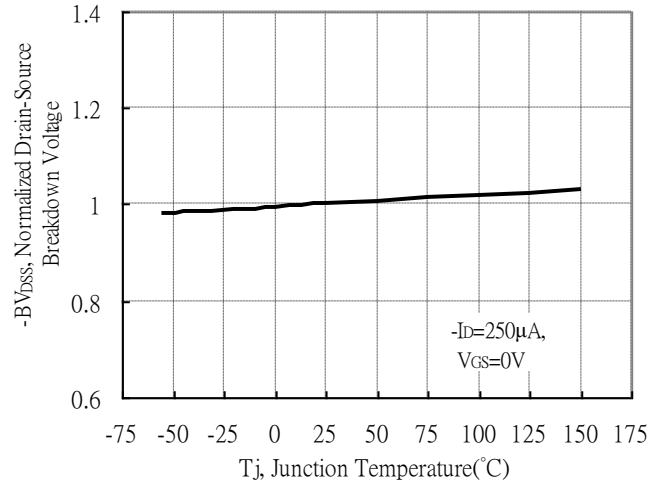


Typical Characteristics : Q2(P-channel)

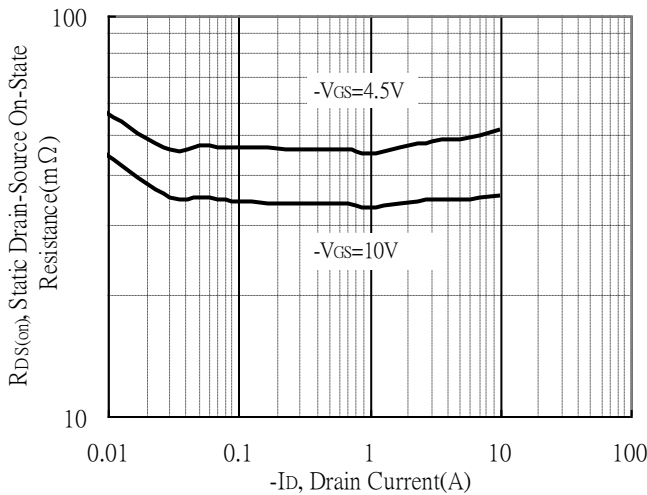
Typical Output Characteristics



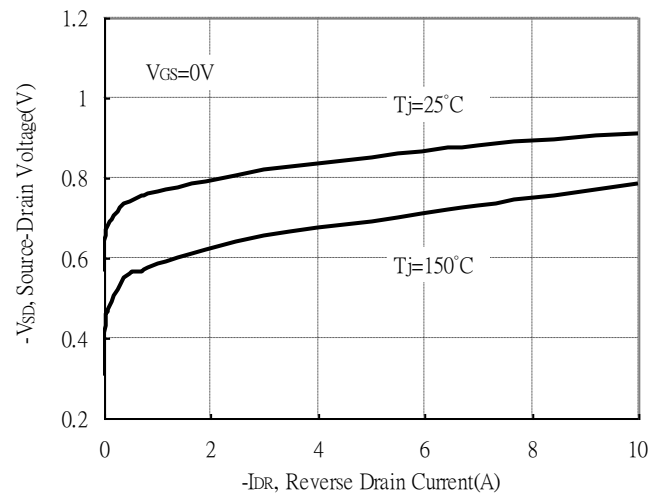
Breakdown Voltage vs Ambient Temperature



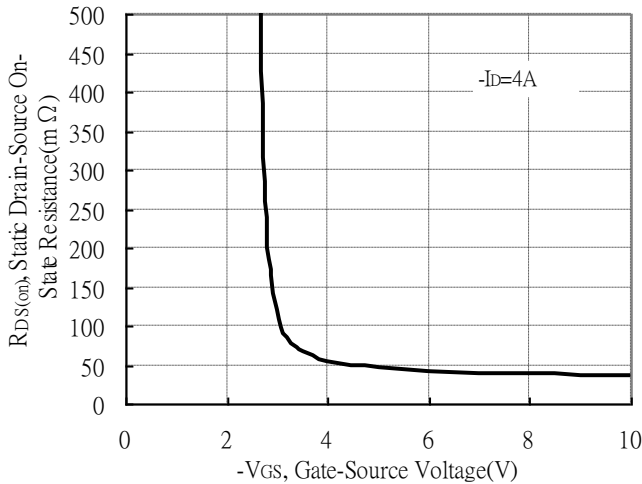
Static Drain-Source On-State resistance vs Drain Current



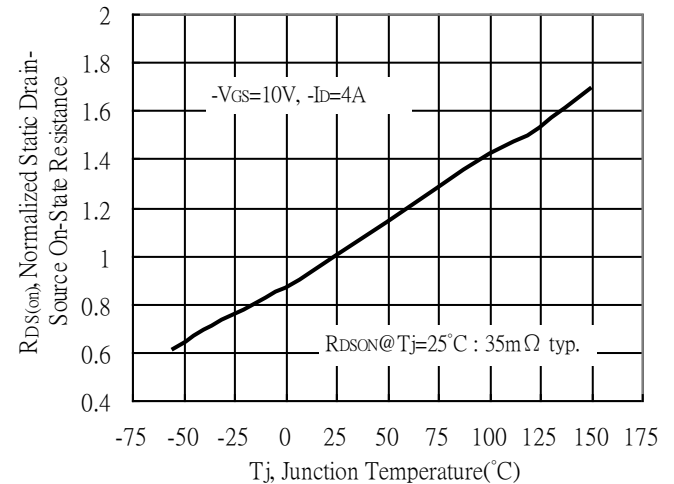
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

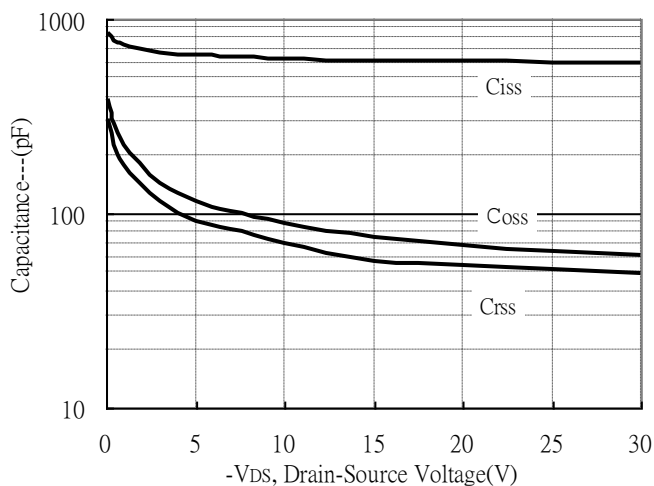


Drain-Source On-State Resistance vs Junction Temperature

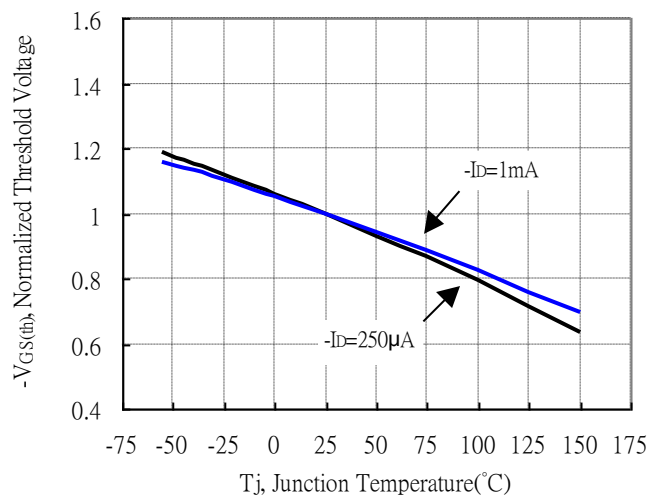


Typical Characteristics(Cont.) : Q2(P-channel)

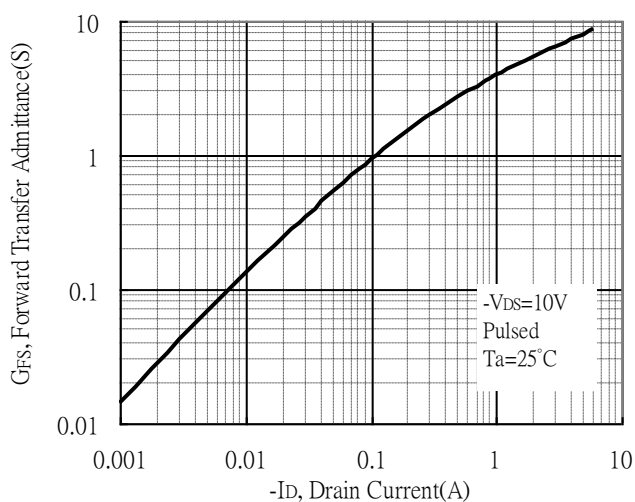
Capacitance vs Drain-to-Source Voltage



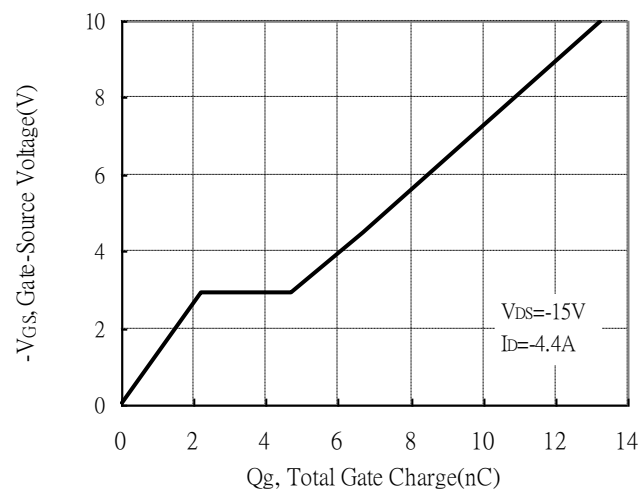
Threshold Voltage vs Junction Temperature



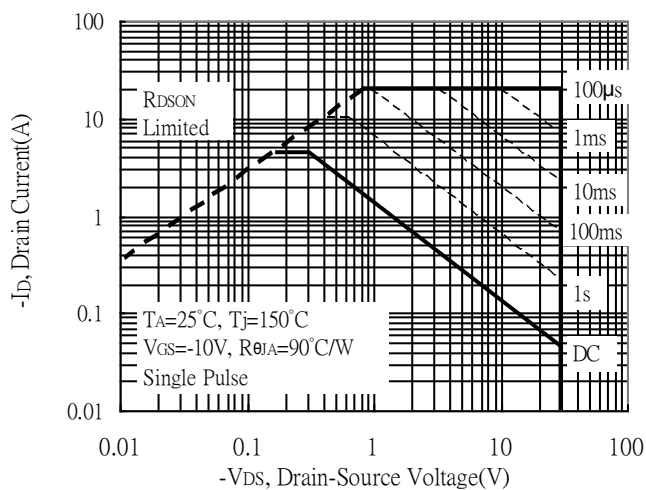
Forward Transfer Admittance vs Drain Current



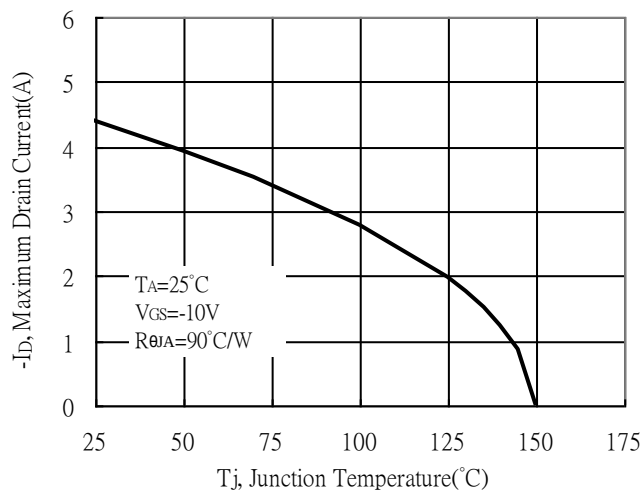
Gate Charge Characteristics



Maximum Safe Operating Area

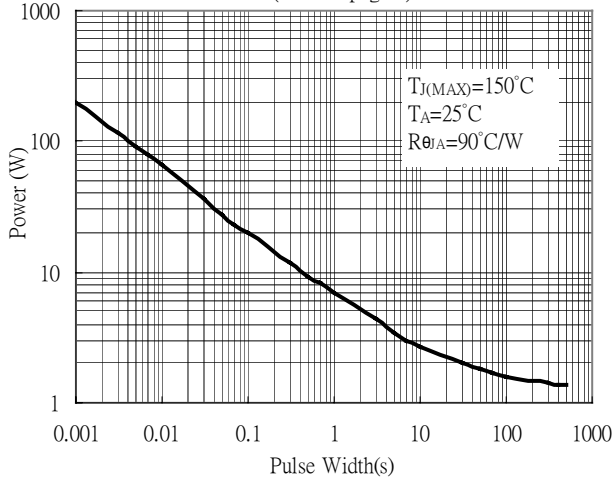


Maximum Drain Current vs Junction Temperature

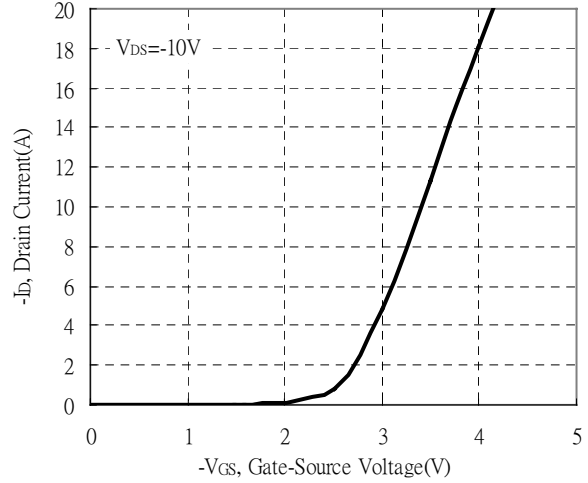


Typical Characteristics(Cont.) : Q2(P-channel)

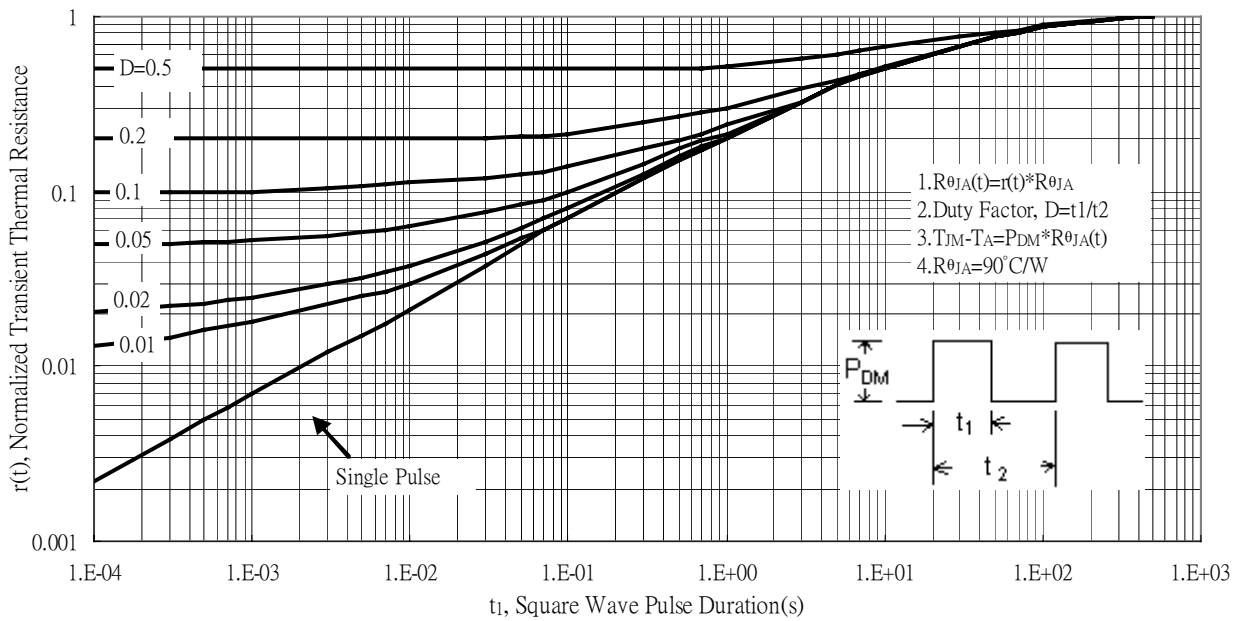
Single Pulse Power Rating, Junction to Ambient
 (Note on page 2)



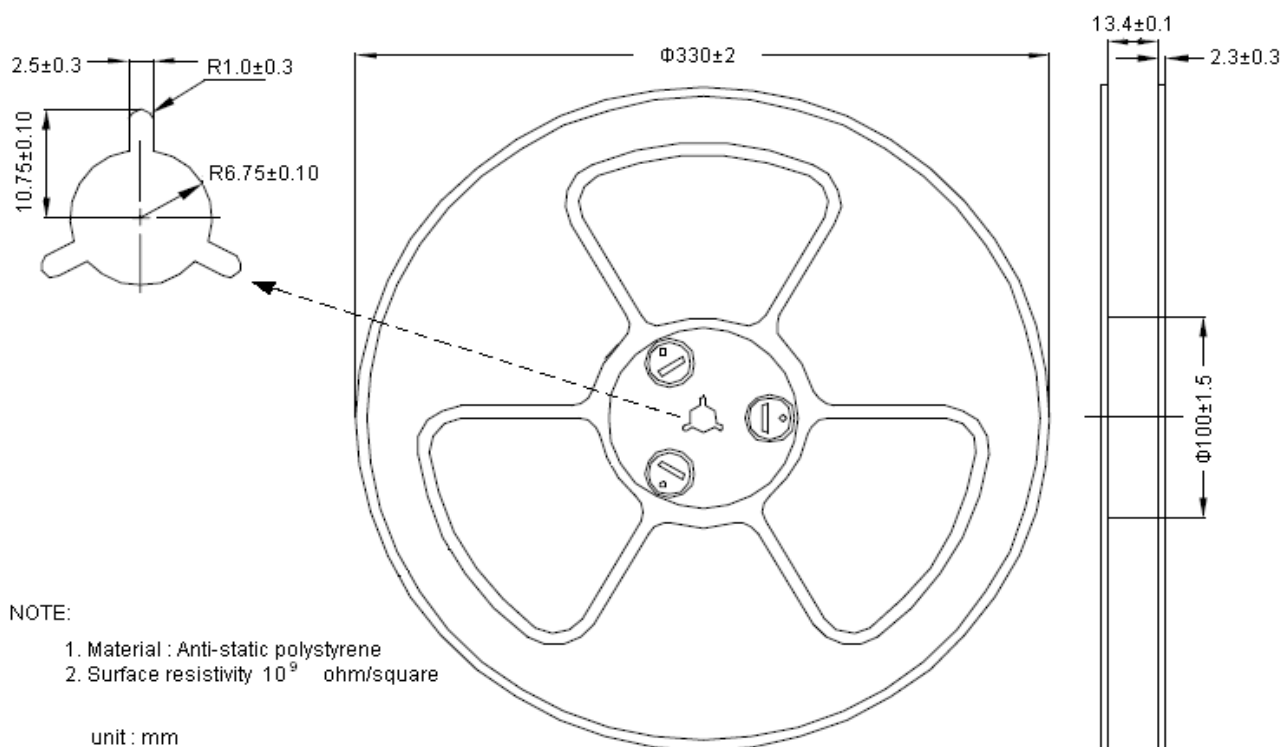
Typical Transfer Characteristics



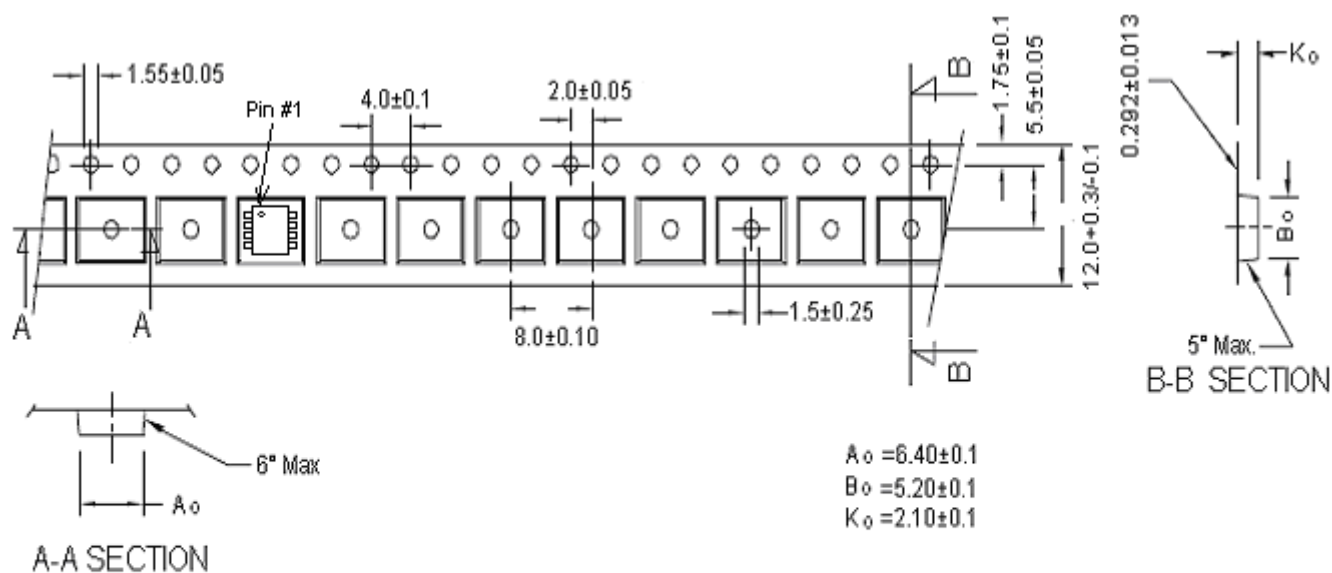
Transient Thermal Response Curves



Reel Dimension



Carrier Tape Dimension

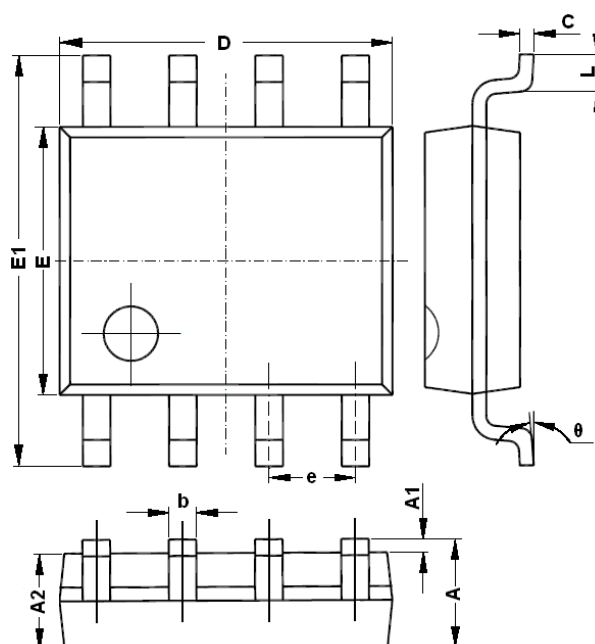


Notes:

1. 10 sprocket hole pitch cumulative tolerance ± 0.2 .
2. Camber not to exceed 1mm in 100mm.
3. Material: conductive black polystyrene
4. A_0 & B_0 measured on a plane 0.3mm above the bottom of the pocket.
5. K_0 measured from a plane on the inside bottom of the pocket to the top surface of the carrier.
6. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole.

Unit : millimeter

SOP-8 Dimension



Marking:

Device Name

9930

Date Code

□ □ □ □

Date Code(counting from left to right) :

1st code: year code, the last digit of Christian year

2nd code : month code, Jan→A, Feb→B, Mar→C, Apr→D

May→E, Jun→F, Jul→G, Aug→H, Sep→J,

Oct→K, Nov→L, Dec→M

3rd and 4th codes : production serial number, 01~99

8-Lead SOP-8 Plastic Package

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069	E	3.800	4.000	0.150	0.157
A1	0.100	0.250	0.004	0.010	E1	5.800	6.200	0.228	0.244
A2	1.350	1.550	0.053	0.061	e	1.270 (BSC)		0.050 (BSC)	
b	0.330	0.510	0.013	0.020	L	0.400	1.270	0.016	0.050
c	0.170	0.250	0.006	0.010	θ	0	8°	0	8°
D	4.700	5.100	0.185	0.200					